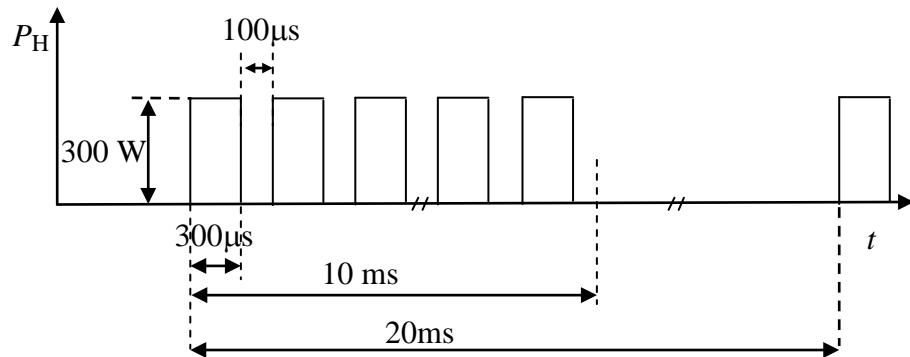


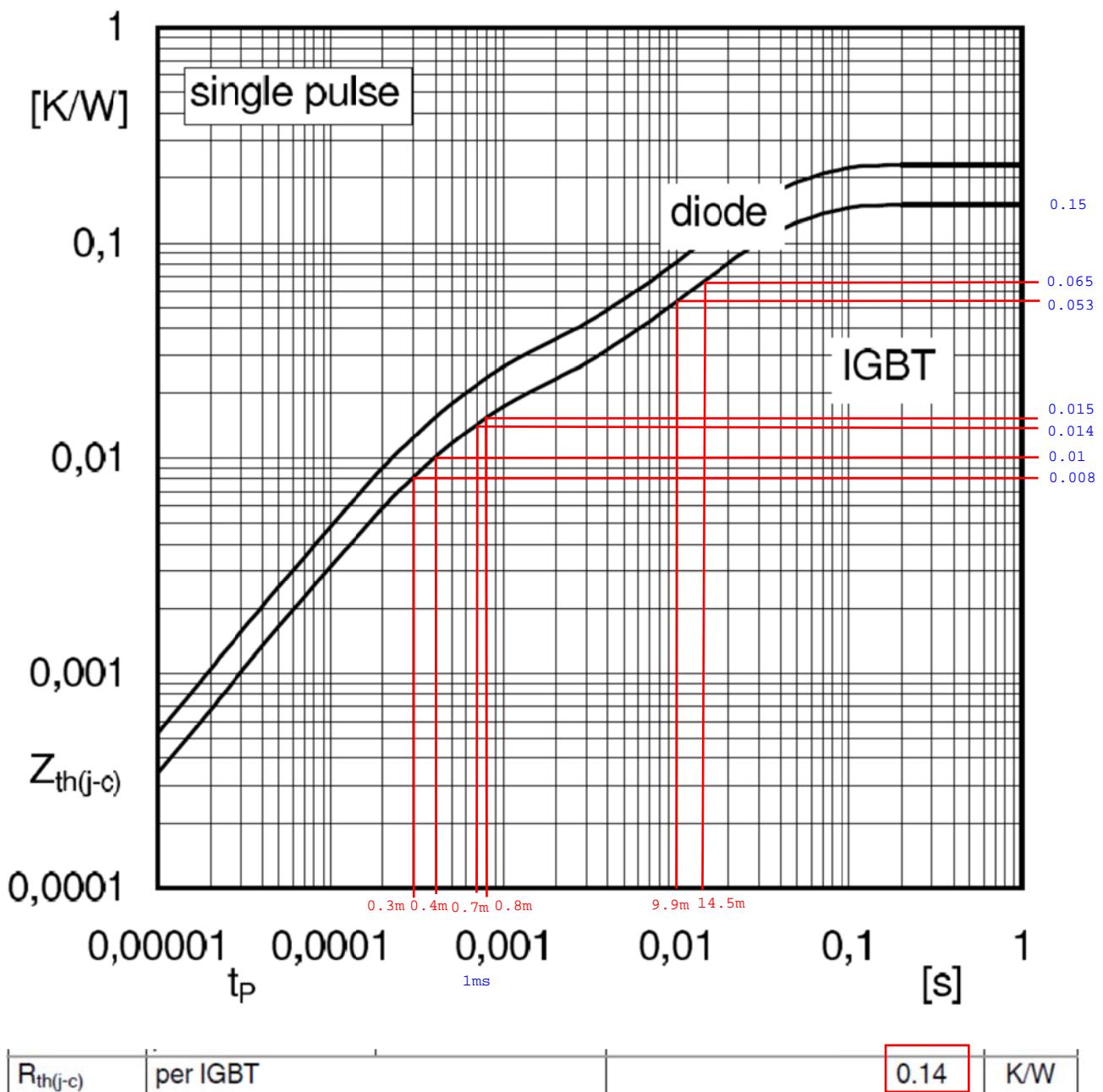
ELEC-E8421 Tehoelektriikan komponentit

Harjoitus 6.

1. SEMiX223GB12Vs module IGBT losses are as shown in below picture, 20 ms continuous cycle with 10 ms of 25 identical pulses, lasting 300 us and between time of 100 us. Using accelerated superposition principle, determine the IGBT junction to case temperature at the end last pulse. Required figures and series is on the next page.



2. Disk type diode contact area diameter is 17 mm and losses are 205 W. The cooling case which is 2 sided should have a thermal resistance less than 0.26 K/W.
 - a) choose a cooling element using following datasheets
 - b) What is the minimum airflow required
 - c) what is the pressure difference between start and end of the cooling element
 - d) Calculate, which values you get for the thermal resistance when using volume and surface are based natural cooling experimental equations of 8.18 and 8.16 in the book, Compare values to the datasheets
(Note! All necessary measures are not visible in the datasheet, but you may use ruler to determine remaining metrics!)
 - e) using figure 8.11 define necessary airflow, compare to value in b). What causes the difference?



$$Z_{th}(t) = R_1 \left(1 - \exp\left(-\frac{t}{\tau_1}\right) \right) + R_2 \left(1 - \exp\left(-\frac{t}{\tau_2}\right) \right) \quad (4-2)$$

For SEMiX modules, the coefficients R_1 , τ_1 , and R_2 , τ_2 can be determined using the data sheet values as given in Tab. 1-1.

	IGBT, CAL diode	Thyristor, rectifier diode
R_1	[K/W]	$0.9 \times R_{th(j-c)}$
R_2	[K/W]	$0.1 \times R_{th(j-c)}$
τ_1	[sec]	0.03
τ_2	[sec]	0.0005

Tab. 1-1 Parameters for $Z_{th(j-c)}$ calculation using equation (4-2)

SEMiX223GB12Vs



SEMiX223GB12Vs

Features

- Homogeneous Si
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- UL recognised file no. E63532

Typical Applications*

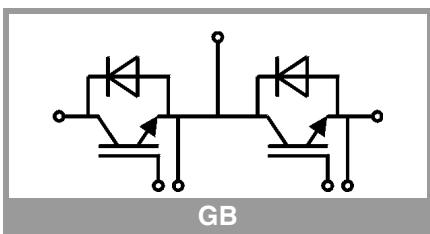
- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperature limited to $T_C=125^\circ\text{C}$ max.
- Product reliability results are valid for $T_j=150^\circ\text{C}$
- Dynamic values apply to the following combination of resistors:
 $R_{Gon,main} = 2,9 \Omega$
 $R_{Goff,main} = 2,9 \Omega$
 $R_{G,X} = 2,2 \Omega$
 $R_{E,X} = 0,5 \Omega$

Absolute Maximum Ratings		Values	Unit
Symbol	Conditions		
IGBT			
V_{CES}	$T_j = 25^\circ\text{C}$	1200	V
I_C	$T_j = 175^\circ\text{C}$	323	A
		246	A
I_{Cnom}		225	A
I_{CRM}	$I_{CRM} = 3 \times I_{Cnom}$	675	A
V_{GES}		-20 ... 20	V
t_{psc}	$V_{CC} = 720 \text{ V}$ $V_{GE} \leq 15 \text{ V}$ $V_{CES} \leq 1200 \text{ V}$	10	μs
T_j		-40 ... 175	$^\circ\text{C}$
Inverse diode			
I_F	$T_j = 175^\circ\text{C}$	263	A
		197	A
I_{Fnom}		225	A
I_{FRM}	$I_{FRM} = 3 \times I_{Fnom}$	675	A
I_{FSM}	$t_p = 10 \text{ ms}, \sin 180^\circ, T_j = 25^\circ\text{C}$	1161	A
T_j		-40 ... 175	$^\circ\text{C}$
Module			
$I_{t(RMS)}$	$T_{\text{terminal}} = 80^\circ\text{C}$	600	A
T_{stg}		-40 ... 125	$^\circ\text{C}$
V_{isol}	AC sinus 50Hz, $t = 1 \text{ min}$	4000	V

Characteristics		min.	typ.	max.	Unit
Symbol	Conditions				
IGBT					
$V_{CE(sat)}$	$I_C = 225 \text{ A}$ $V_{GE} = 15 \text{ V}$ chiplevel	$T_j = 25^\circ\text{C}$	1.85	2.3	V
		$T_j = 150^\circ\text{C}$	2.3	2.55	V
V_{CE0}		$T_j = 25^\circ\text{C}$	0.94	1.04	V
		$T_j = 150^\circ\text{C}$	0.88	0.98	V
r_{CE}	$V_{GE} = 15 \text{ V}$	$T_j = 25^\circ\text{C}$	4.0	5.6	$\text{m}\Omega$
		$T_j = 150^\circ\text{C}$	6.1	7.0	$\text{m}\Omega$
$V_{GE(th)}$	$V_{GE}=V_{CE}, I_C = 9 \text{ mA}$		5.5	6	6.5
I_{CES}	$V_{GE} = 0 \text{ V}$ $V_{CE} = 1200 \text{ V}$	$T_j = 25^\circ\text{C}$	0.1	0.3	mA
C_{ies}		$T_j = 150^\circ\text{C}$			mA
C_{oes}	$V_{CE} = 25 \text{ V}$ $V_{GE} = 0 \text{ V}$	$f = 1 \text{ MHz}$	13.5		nF
C_{res}		$f = 1 \text{ MHz}$	1.33		nF
Q_G	$V_{GE} = -8 \text{ V} \dots +15 \text{ V}$		1.33		nF
R_{Gint}			2460		nC
			3.33		Ω
$t_{d(on)}$	$V_{CC} = 600 \text{ V}$	$T_j = 150^\circ\text{C}$	470		ns
t_r	$I_C = 225 \text{ A}$ $V_{GE} = \pm 15 \text{ V}$	$T_j = 150^\circ\text{C}$	72		ns
E_{on}	$R_{G\text{ on}} = 3.8 \Omega$	$T_j = 150^\circ\text{C}$	19.9		mJ
$t_{d(off)}$	$R_{G\text{ off}} = 3.8 \Omega$	$T_j = 150^\circ\text{C}$	665		ns
t_f	$di/dt_{on} = 3200 \text{ A}/\mu\text{s}$ $di/dt_{off} = 2000 \text{ A}/\mu\text{s}$	$T_j = 150^\circ\text{C}$	109		ns
E_{off}	$du/dt_{off} = 6600 \text{ V}/\mu\text{s}$	$T_j = 150^\circ\text{C}$	27.2		mJ
$R_{th(j-c)}$	per IGBT		0.14		K/W



SEMiX223GB12Vs



SEMiX223GB12Vs

Features

- Homogeneous Si
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability
- UL recognised file no. E63532

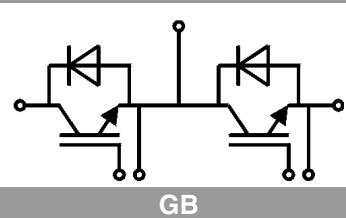
Typical Applications*

- AC inverter drives
- UPS
- Electronic Welding

Remarks

- Case temperature limited to $T_C=125^\circ\text{C}$ max.
- Product reliability results are valid for $T_j=150^\circ\text{C}$
- Dynamic values apply to the following combination of resistors:
 $R_{Gon,main} = 2,9 \Omega$
 $R_{Goff,main} = 2,9 \Omega$
 $R_{G,X} = 2,2 \Omega$
 $R_{E,X} = 0,5 \Omega$

Characteristics		Symbol	Conditions	min.	typ.	max.	Unit						
Inverse diode													
Symbol													
$V_F = V_{EC}$	$I_F = 225 \text{ A}$		$T_j = 25^\circ\text{C}$		2.2	2.49	V						
	$V_{GE} = 0 \text{ V}$ chip		$T_j = 150^\circ\text{C}$										
V_{FO}			$T_j = 25^\circ\text{C}$	1.1	1.3	1.5	V						
			$T_j = 150^\circ\text{C}$										
r_F			$T_j = 25^\circ\text{C}$	3.6	3.9	4.4	$\text{m}\Omega$						
			$T_j = 150^\circ\text{C}$										
I_{RRM}	$I_F = 225 \text{ A}$		$T_j = 150^\circ\text{C}$			210	A						
Q_{rr}	$\frac{dI}{dt}_{\text{off}} = 3400 \text{ A}/\mu\text{s}$		$T_j = 150^\circ\text{C}$			39.4	μC						
E_{rr}	$V_{GE} = -15 \text{ V}$		$T_j = 150^\circ\text{C}$			16.4	mJ						
$R_{th(j-c)}$	per diode					0.23	K/W						
Module													
L_{CE}						20	nH						
$R_{CC'+EE'}$	res., terminal-chip		$T_C = 25^\circ\text{C}$			0.7	$\text{m}\Omega$						
			$T_C = 125^\circ\text{C}$			1	$\text{m}\Omega$						
$R_{th(c-s)}$	per module					0.04	K/W						
M_s	to heat sink (M5)					3	Nm						
M_t	to terminals (M6)					2.5	Nm						
w							Nm						
						300	g						
Temperatur Sensor													
R_{100}	$T_c=100^\circ\text{C}$ ($R_{25}=5 \text{ k}\Omega$)					$493 \pm 5\%$	Ω						
$B_{100/125}$	$R_{(T)}=R_{100}\exp[B_{100/125}(1/T-1/T_{100})]; T[\text{K}]$; $\pm 2\%$					3550	K						



SEMiX223GB12Vs

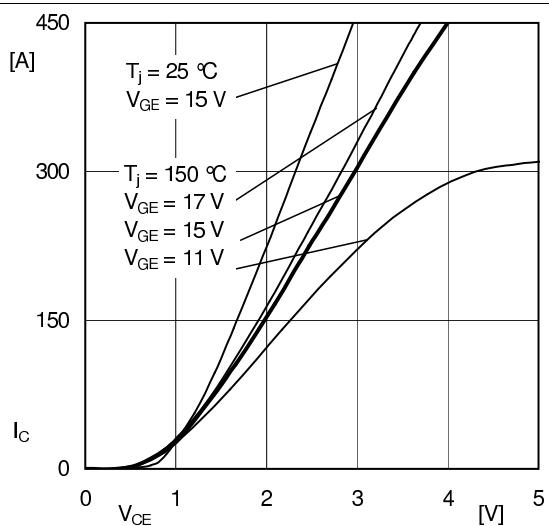


Fig. 1: Typ. output characteristic, inclusive $R_{CC} + EE'$

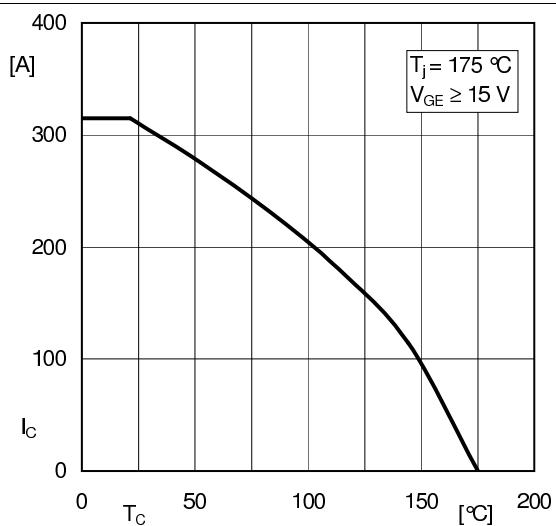


Fig. 2: Rated current vs. temperature $I_C = f(T_C)$

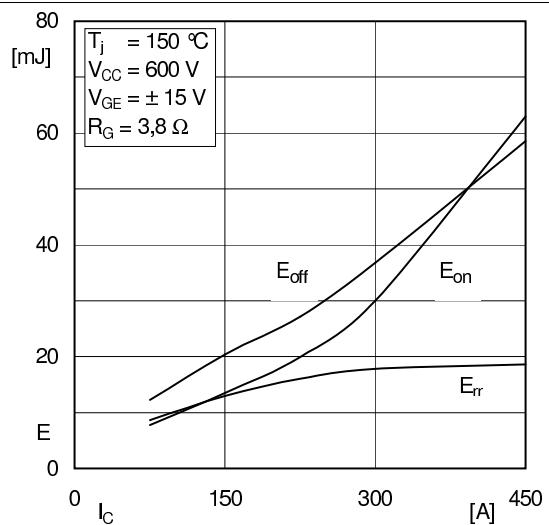


Fig. 3: Typ. turn-on /-off energy = $f(I_C)$

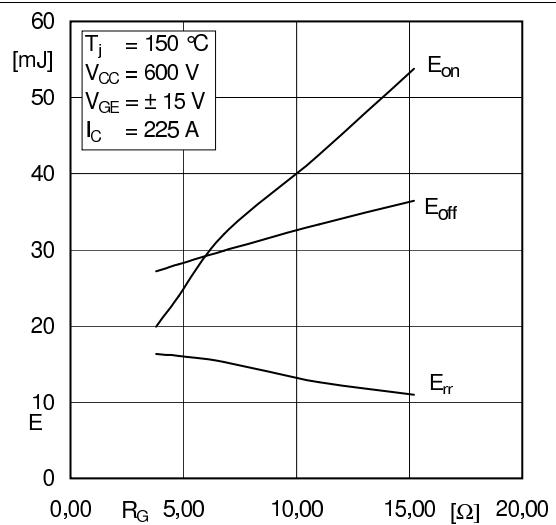


Fig. 4: Typ. turn-on /-off energy = $f(R_G)$

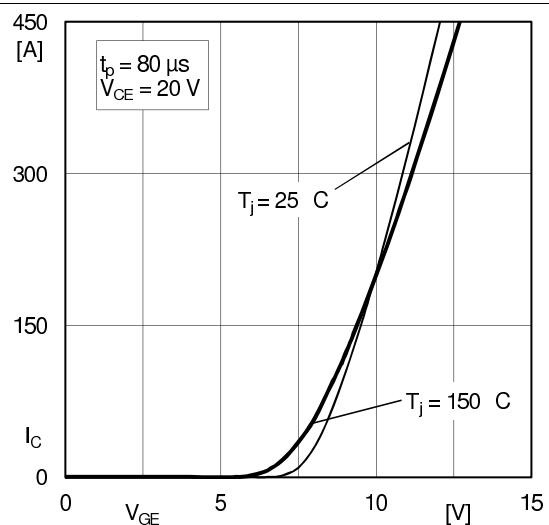


Fig. 5: Typ. transfer characteristic

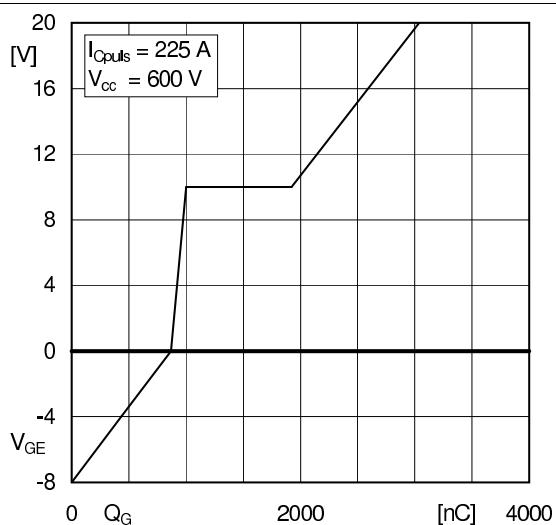


Fig. 6: Typ. gate charge characteristic

SEMiX223GB12Vs

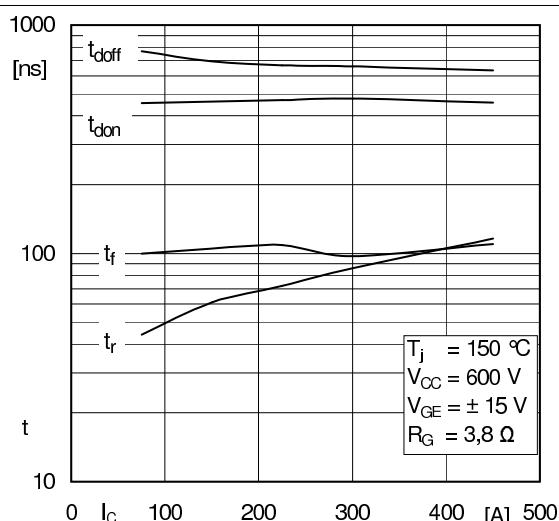


Fig. 7: Typ. switching times vs. I_C

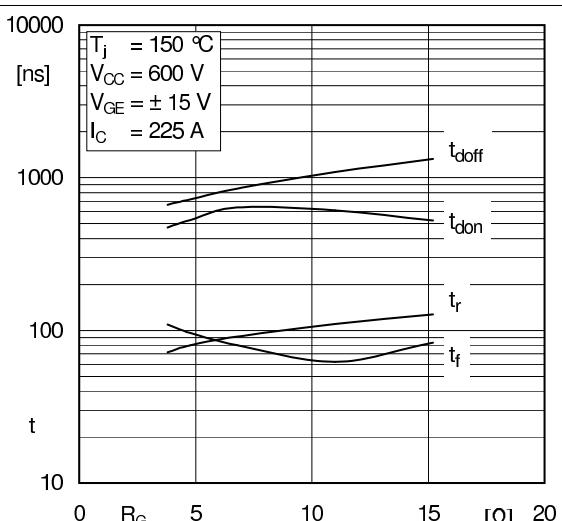


Fig. 8: Typ. switching times vs. gate resistor R_G

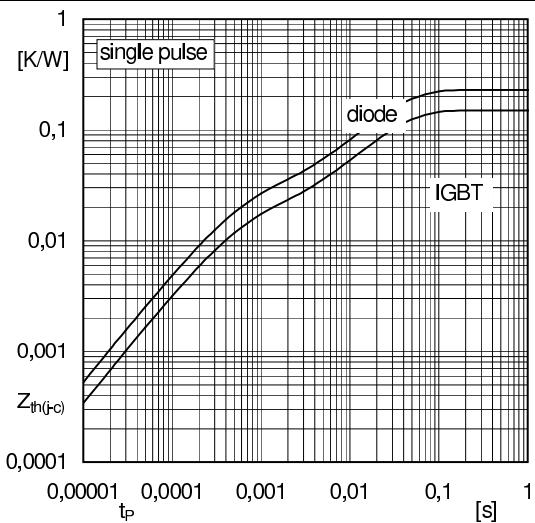


Fig. 9: Typ. transient thermal impedance

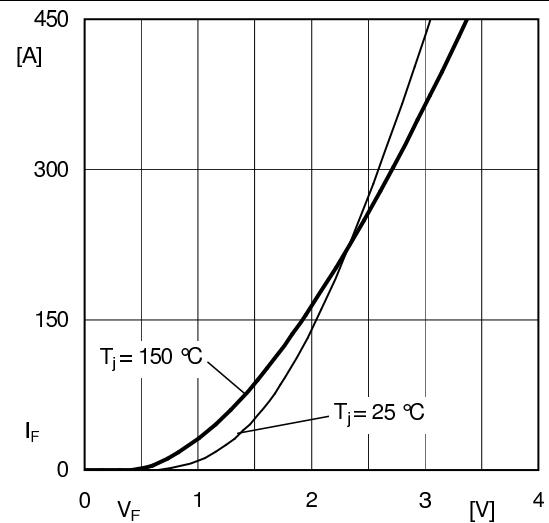


Fig. 10: Typ. CAL diode forward charact., incl. R_{CC+EE}

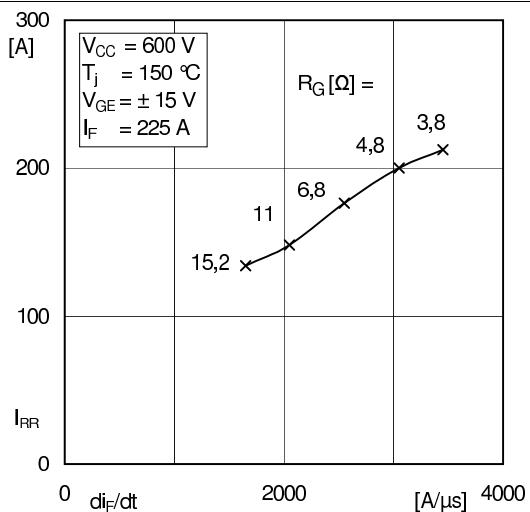


Fig. 11: Typ. CAL diode peak reverse recovery current

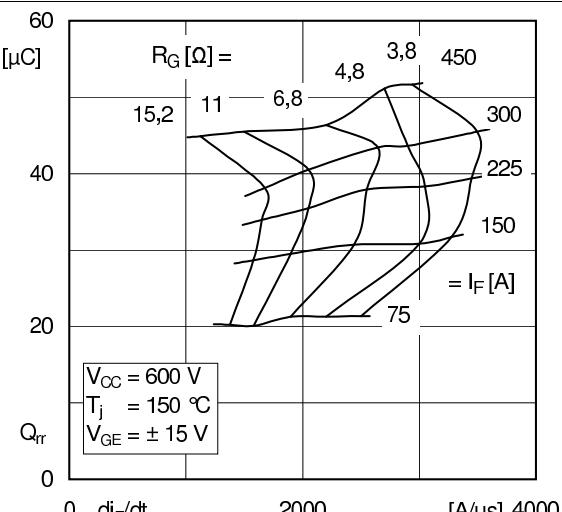
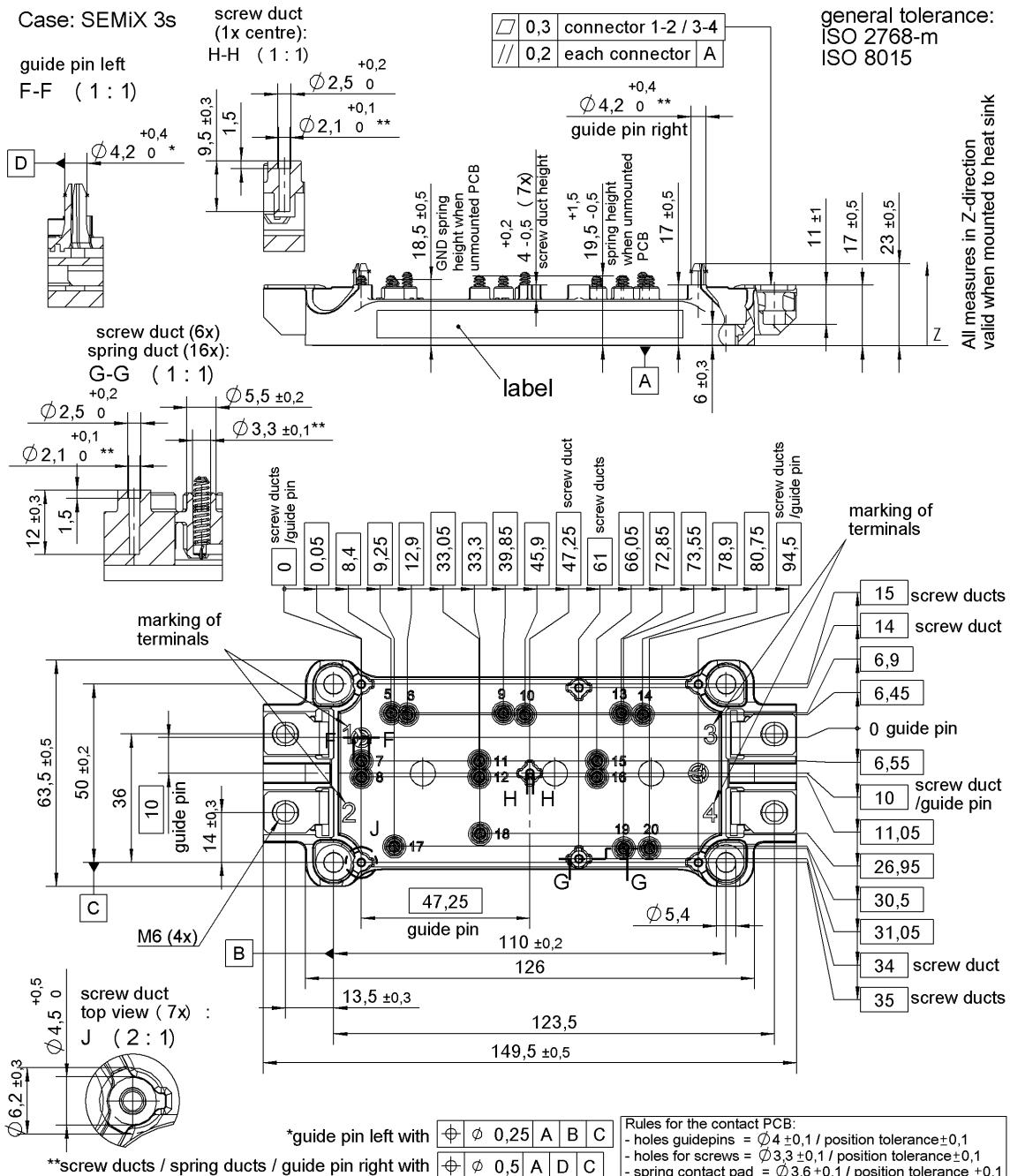
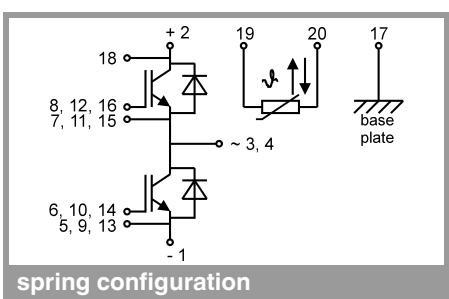


Fig. 12: Typ. CAL diode recovery charge

SEMiX223GB12Vs



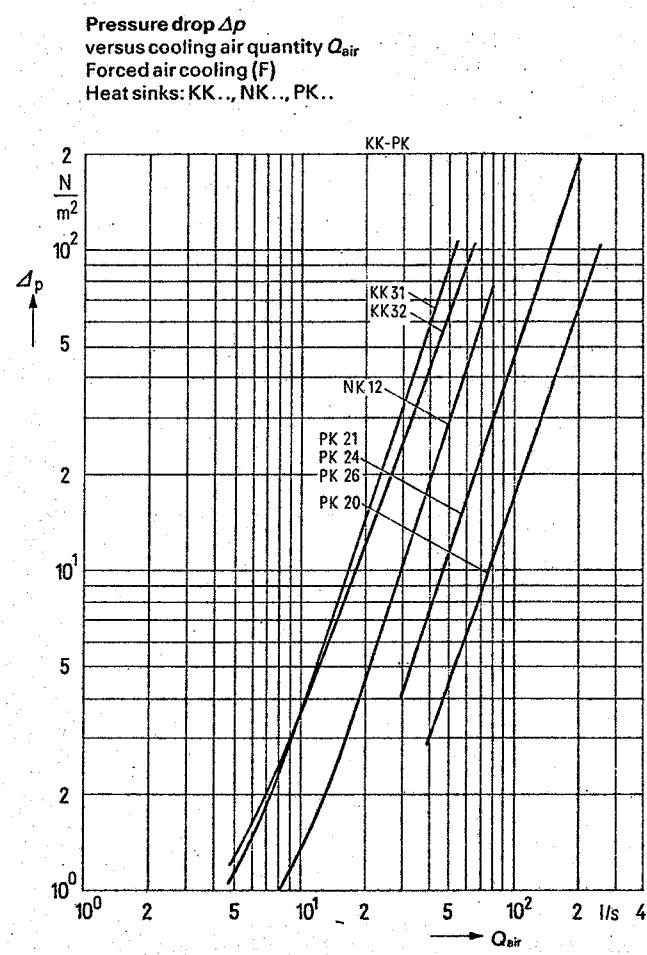
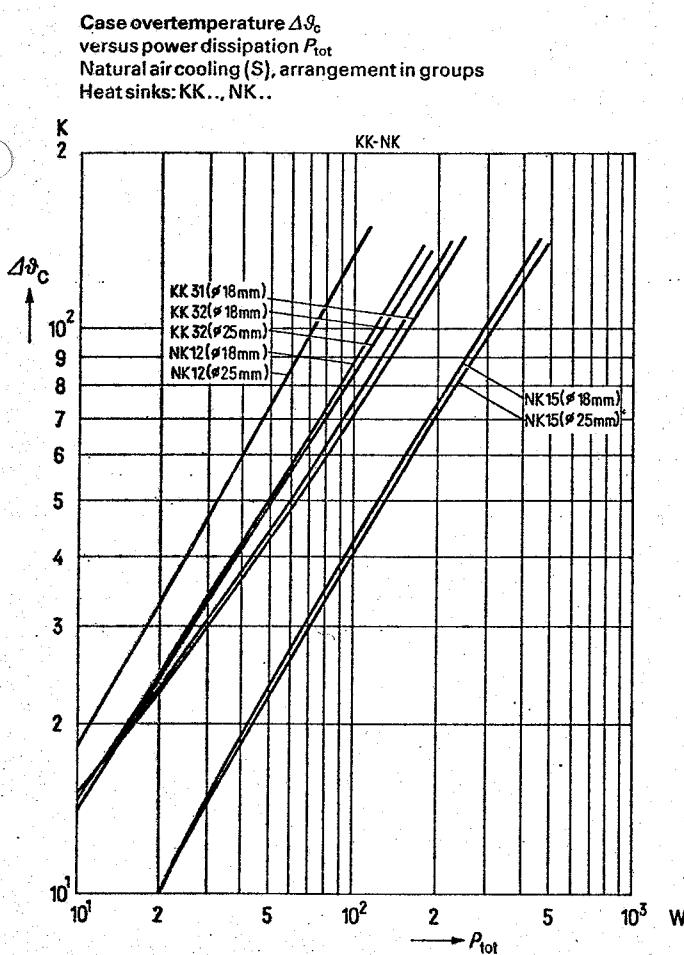
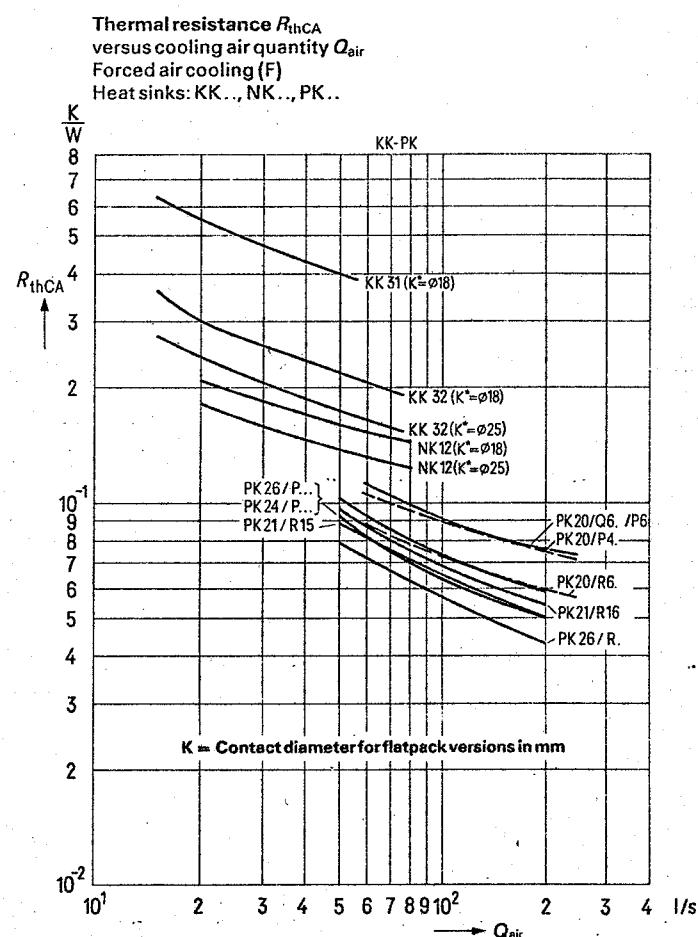
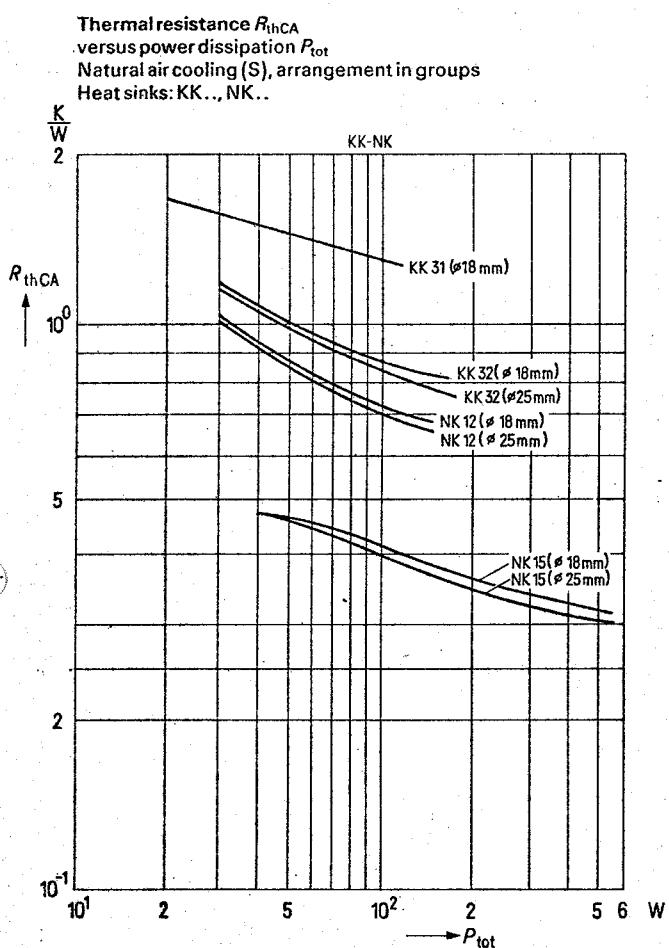
SEMiX 3s



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.

Heat sinks for disc components; air cooling



Heat Sinks

4

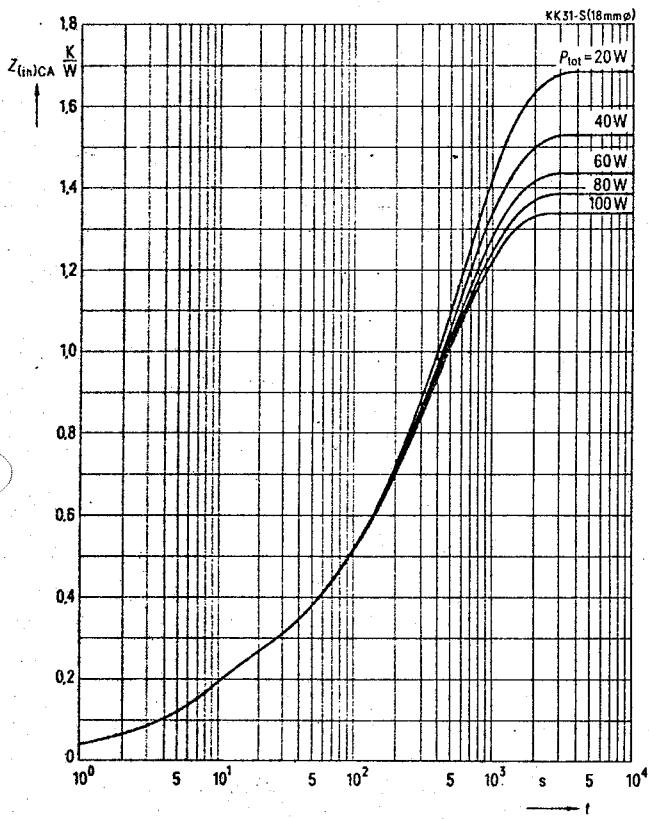
Heat sinks for disc components; air cooling

Transient thermal resistance

incl. heat transfer

Heat sinks KK31 ($K = 18 \text{ mm dia}$)

Natural air cooling (S)

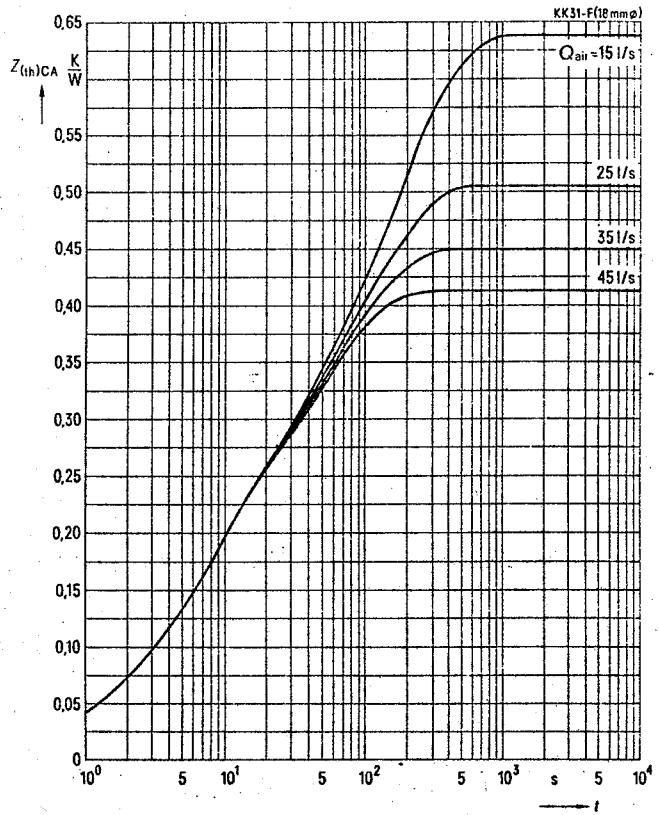


Transient thermal resistance

incl. heat transfer

Heat sinks KK31 ($K = 18 \text{ mm dia}$)

Forced air cooling (F)

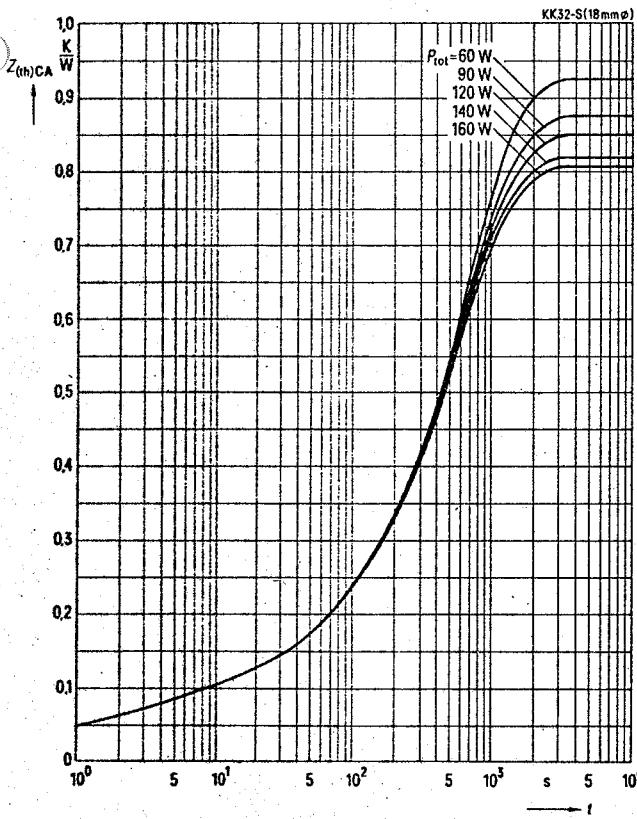


Transient thermal resistance

incl. heat transfer

Heat sinks KK32 ($K = 18 \text{ mm dia}$)

Natural air cooling (S)

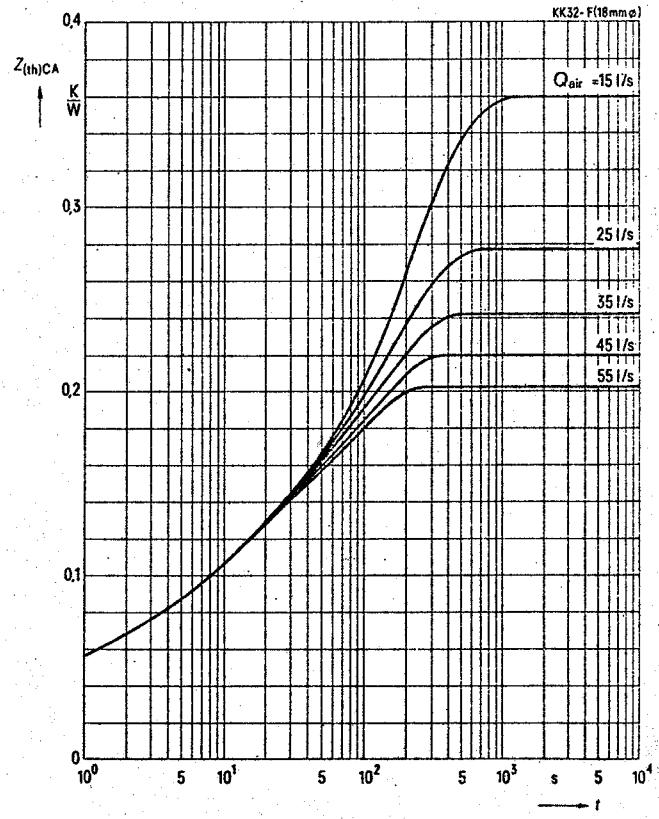


Transient thermal resistance

incl. heat transfer

Heat sinks KK32 ($K = 18 \text{ mm dia}$)

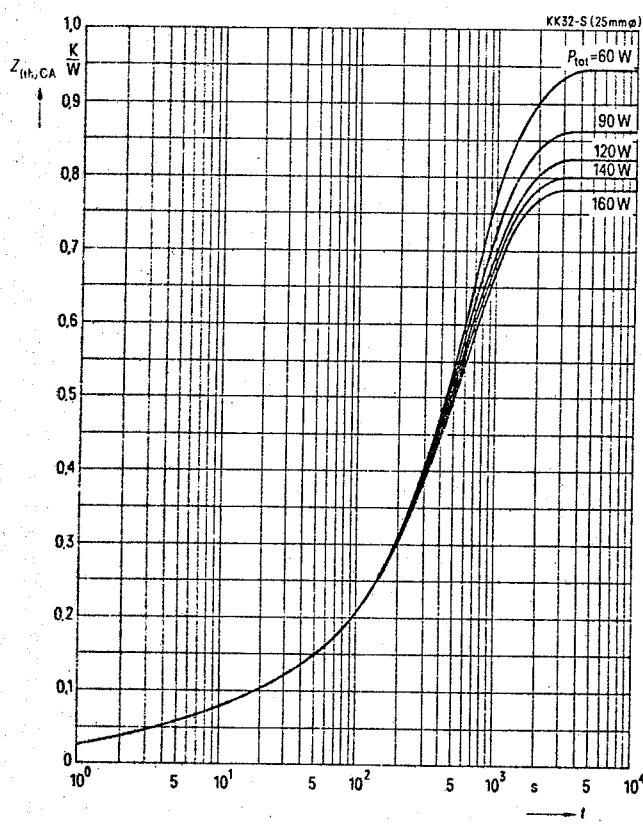
Forced air cooling (F)



Heat sinks for disc components; air cooling

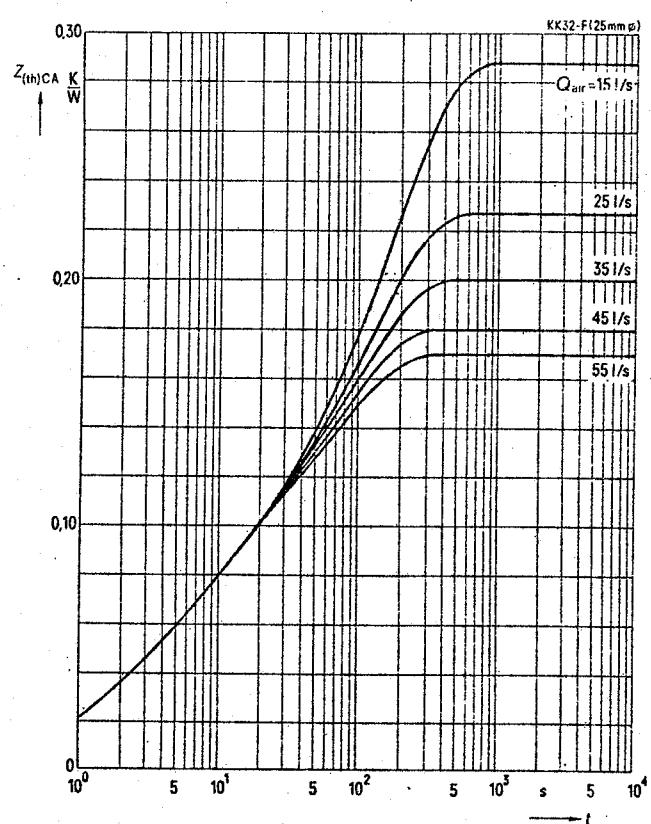
Transient thermal resistance incl. heat transfer

Heat sinks KK 32 ($K = 25 \text{ mm dia}$)
Natural air cooling (S)



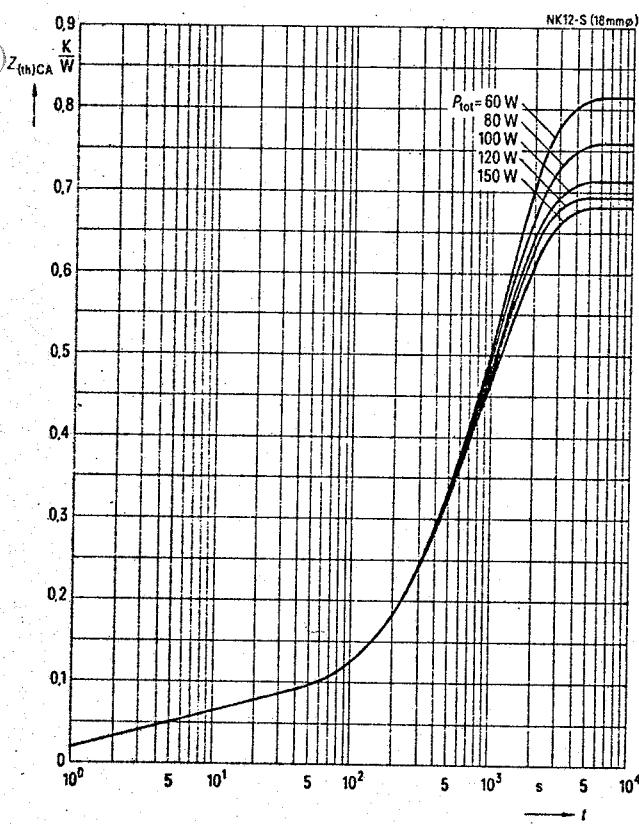
Transient thermal resistance incl. heat transfer

Heat sinks KK 32 ($K = 25 \text{ mm dia}$)
Forced air cooling (F)



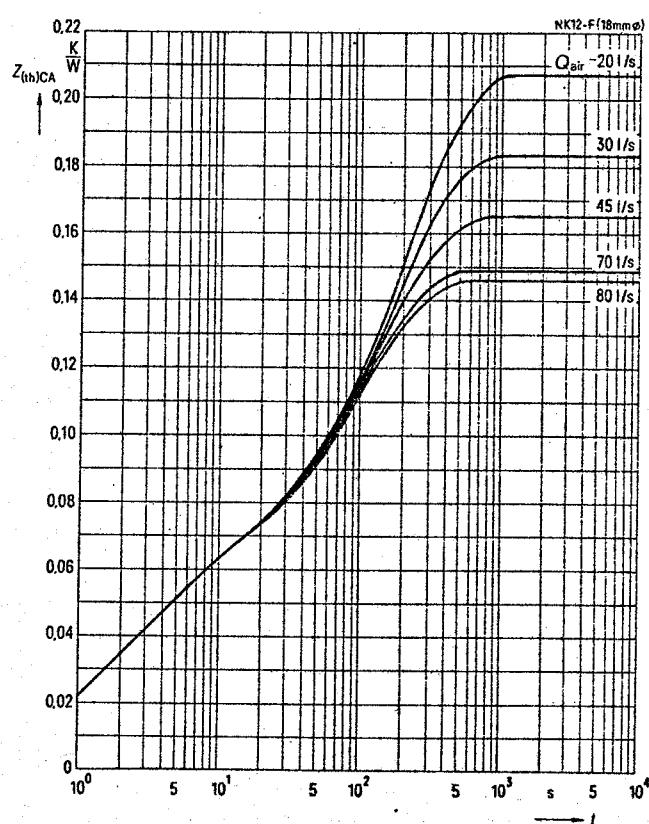
Transient thermal resistance incl. heat transfer

Heatsinks NK 12 ($K = 18 \text{ mm dia}$)
Natural air cooling (S)



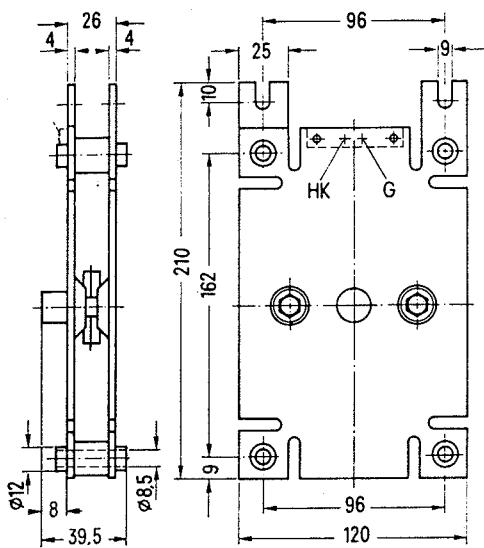
Transient thermal resistance incl. heat transfer

Heatsinks NK 12 ($K = 18 \text{ mm dia}$)
Forced air cooling (F)

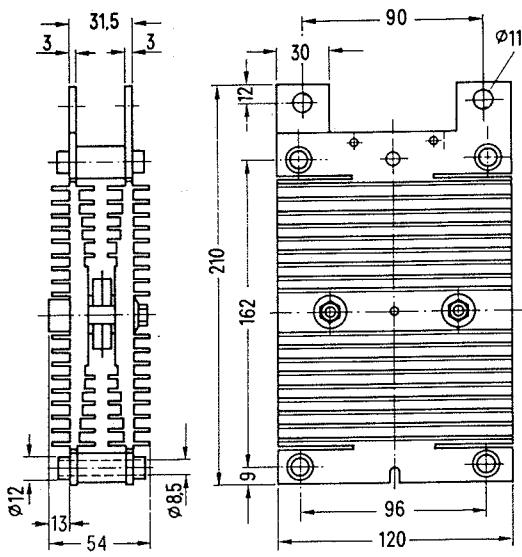


Heat Sinks

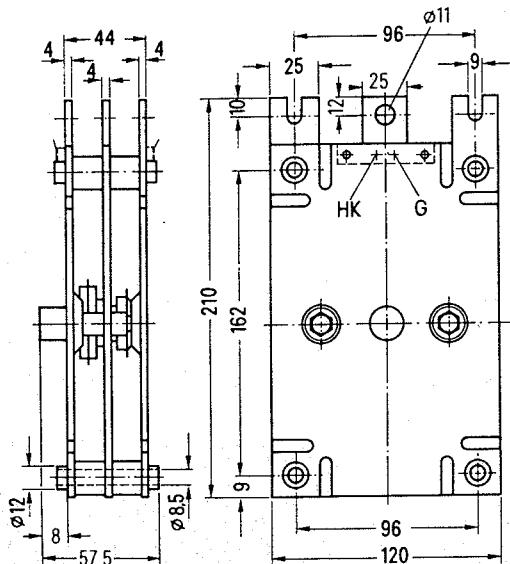
Heat sinks for disc components; air cooling



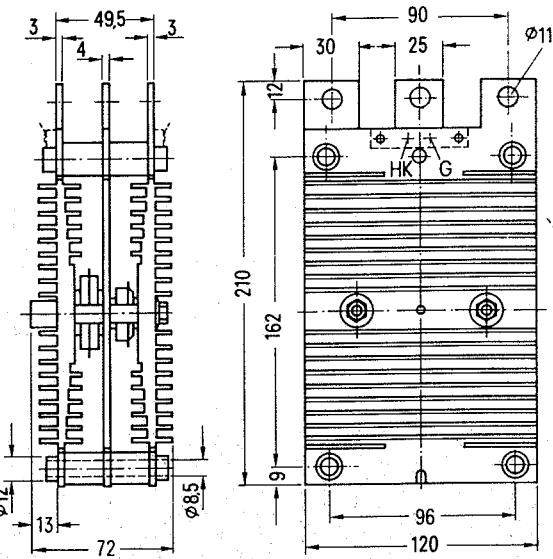
KK31
Weight: 500 g



KK32
Weight: 950 g

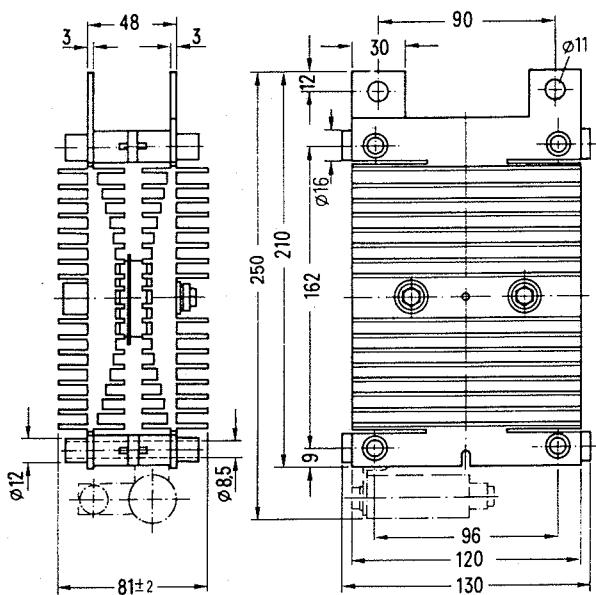


KK33
Weight: 800 g

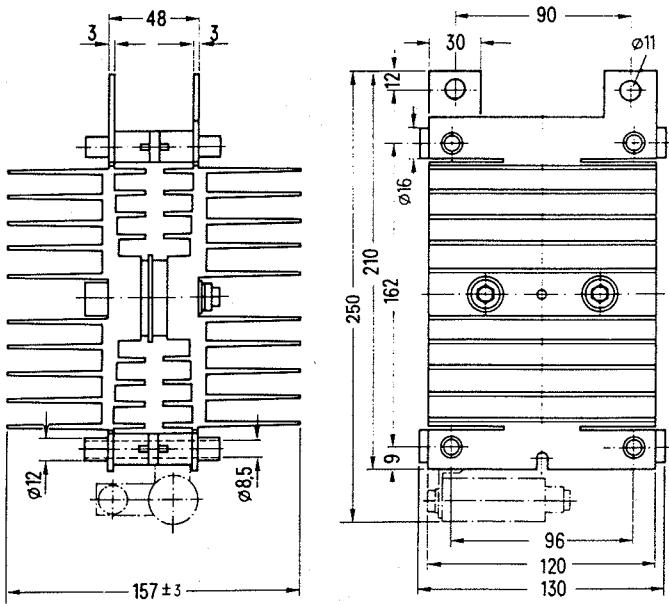


KK34
Weight: 1200 g

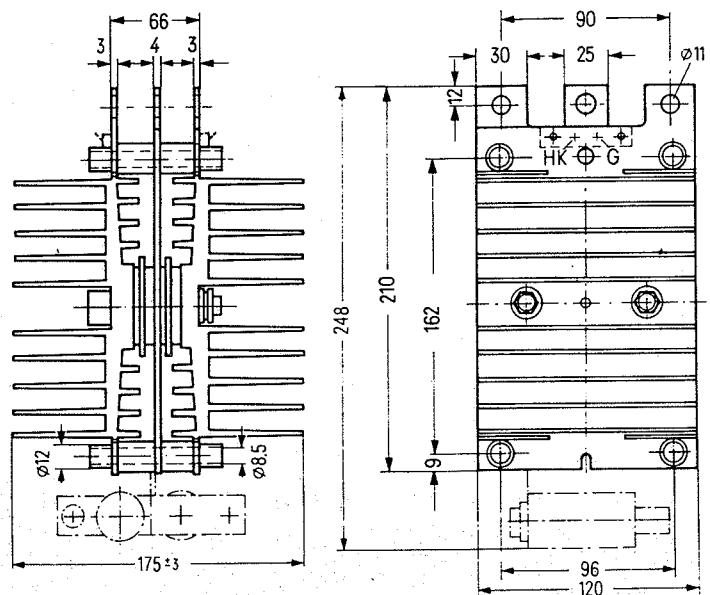
Heat sinks for disc components; air cooling



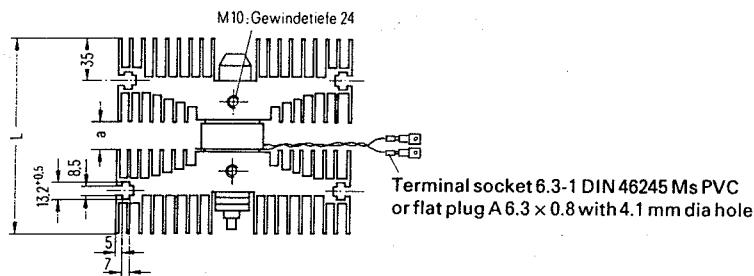
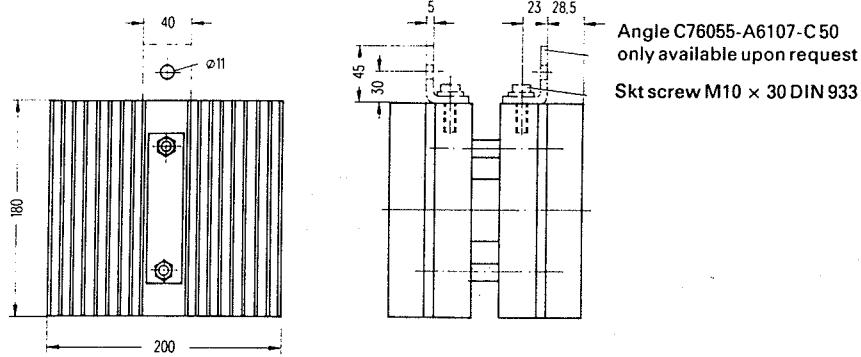
NK12
Weight: 1800 g



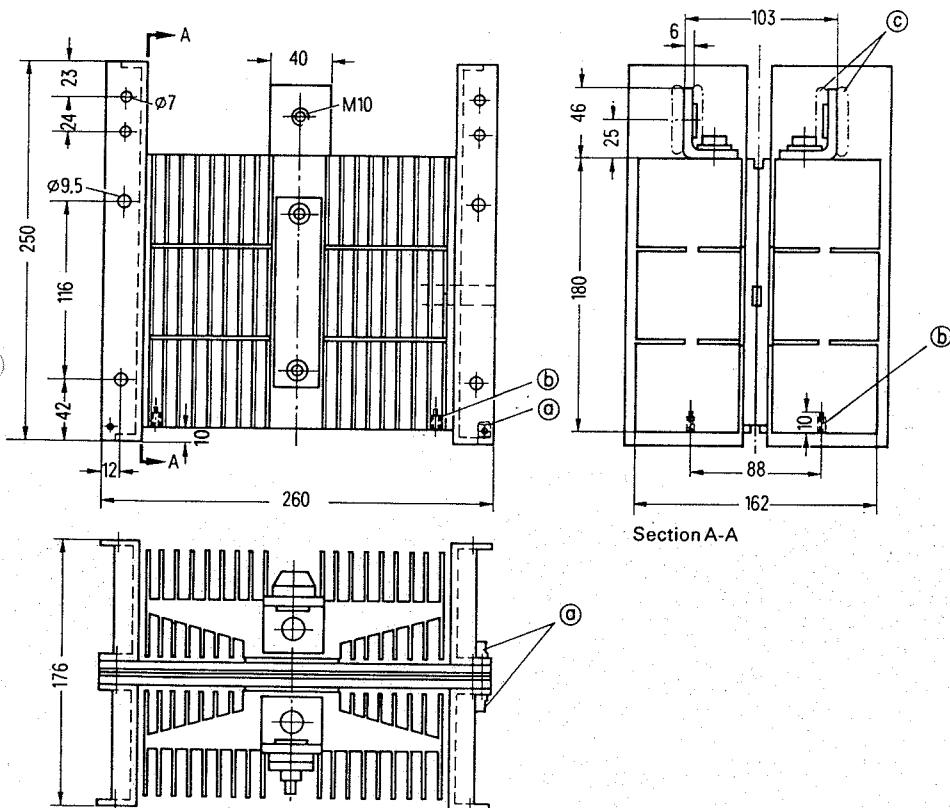
NK15
Weight: 2400 g



NK16
Weight: 2600 g



PK 20
Weight: 7,5kg



PK 21
PK 24
PK 26
Weight: 11,5kg